Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/626,011	DE WAAL, ABRAHAM B.	
Examiner	Art Unit	

TuyetLien (Lien) T. Tran

2179

SEARCHED			
Class	Subclass	Date	Examiner
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INTERFERENCE SEARCHED			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Attached updated EAST search history	10/2/2007	П
consulted with Ba Huynh, PPE 2179	10/2/2007	π